Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/605,160	CHIU, WEN-PIN
Examiner	Art Unit
Rodney G. McDonald	1753

SEARCHED					
Class	Subclass	Date	Examiner		
204	192.12	2/15/07	m		
1	192-17				
	192.15				
	192.3				
	298.06				
201	298,11	2/15/07	1		
		,			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
None	2/18/07	m		
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